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# Pushing Efficiency Limits for Semitransparent Perovskite Solar Cells

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#### ABSTRACT

While perovskite-based semitransparent solar cells deliver competitive levels of transparency and efficiency to be envisioned for urban infrastructures, the complexity and sensitivity of their processing conditions remain challenging. Here, we introduce two robust protocols for the processing of sub-100 nm perovskite films, allowing fine-tuning of the active layer without compromising the crystallinity and quality of the semiconductor. Specifically, we demonstrate that a method based on solvent-induced crystallization with a rapid drying step affords perovskite solar cells with 37% average visible transmittance (AVT) and 7.8% PCE. This process enhances crystallization with a preferential phase orientation presumably at the interface, yielding a high fill factor of 72.3%. The second method is based on a solvent-solvent extraction protocol, enabling active layer films as thin as 40 nm and featuring room-temperature crystallization in ambient environment on a few second time span. As a result, we demonstrate a maximum AVT of 46% with an efficiency of 3.6%, which is the highest combination of efficiency and transparency for a full device stack to date. By combining the two methods presented here we cover a broad range of thicknesses vs. transparency values and confirm that solvent-induced crystallization represents a powerful processing strategy toward high-efficiency semitransparent solar cells. Optical simulations support our experimental findings and provide a global perspective of the opportunities and limitations of semitransparent perovskite photovoltaics.

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#### 1. INTRODUCTION

The development of innovative technologies with improved levels of sustainability that are capable to compete with today's state of the art photovoltaics is challenging, given their widely established deployment methods. Silicon technologies, nowadays leading the market, still have several advantages over second and third generation solar cells for conventional applications. One application with promising potential on getting into the fast track of becoming a realistic contender for silicon technologies is semitransparent photovoltaics. The ability to implement semitransparent solar panels into consumer products such as building integrated elements, e.g. windows, or portable electronics relying on existing infrastructure could potentially lead to an economic boost in the field of photovoltaics. In this regard, Organic Photovoltaics (OPV) offer a unique potential given their characteristics including low manufacturing cost, lightweight, flexibility, intrinsic transparency and, most importantly, solution processability, desirable properties in "roll-to-roll" scalable protocols. Despite its strategic advantages, recent progress on up and coming new technologies such as perovskites have shown significant potential outshining OPV established technologies in terms of efficiency. Latest findings demonstrated efficiencies as high as 10.8% for single-junction opaque OPV devices.<sup>[1,2]</sup> In contrast, perovskite photovoltaics have shown certified efficiencies up to 20.1% within their short time of development since their  $emergence^{[3-6]}$ . In the case of semitransparent photovoltaics, three main areas of focus are recognized in the literature for advancing transparency and performance. Firstly, the strategic selection or design of the absorber material;<sup>[7,8]</sup> second, the realization of light management approaches trough device engineering or nanostructured materials and architectures;<sup>[9]</sup> and third, the development of semitransparent electrodes, combining efficient charge collection and transparency.<sup>[10,11]</sup>

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The demonstration of high efficiencies (>20%), the possibility for low processing temperatures and inexpensive raw materials have positioned perovskites solar cells as promising candidates to replace silicon technologies as leading architecture for solar energy generation.<sup>[3-6]</sup> For these reasons, selecting perovskite-based materials as absorbers for semitransparent photovoltaics in order to pursue high efficiencies became a very attractive strategy.<sup>[10–15]</sup> Regarding the correct selection of the electrode, the utilization of sub-20 nm layers of Au, often combined with capping layers for protection and reduction of energy loss *via* device specular reflection,<sup>[12,15]</sup> silver nanowires (AgNW),<sup>[10,11]</sup> carbon nanotubes (CNT)<sup>[14]</sup> and very recently Graphene single layers<sup>[13]</sup> have led to promising alternatives.

Structural and morphological optimization of the perovskite layer for semitransparent applications is a less explored topic in the literature. One particular approach is based on the inverted structure FTO/TiO<sub>2</sub>/perovskite/Spiro-OMeTAD/Au using a very thin (10 nm) gold metal film. In the latter work, the concept of 'perovskite islands' was introduced achieving 3.5% *PCE* (power conversion efficiency) and an average visible transmittance (AVT) of ~30% (370-740 nm range)<sup>[12]</sup> at best. A limiting trend between the area of the non-uniformly covered absorber film and the corresponding V<sub>oc</sub> and fill factor (FF) of the resulting device was evident and attributed to a parallel diode between the electron transporting layer (ETL) and the hole transporting layer (HTL). Attempts to improving the transparency of the perovskite layer through control of the active layer thickness have been reported before, mostly at the cost of severe performance losses. For instance, Peng You *et al.*, reported a drop in *V<sub>oc</sub>* by ~25%, accompanied by a ~10% loss in FF when decreasing the thickness of the perovskite layer from 350 nm to 150 nm. A maximum efficiency of 12.05% - 5.84% AVT and a minimum of 5.98% *PCE* - 21.76 AVT was obtained.<sup>[13]</sup> Other research groups have also observed similar decreases in V<sub>oc</sub> as the

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perovskite layer film becomes thinner. Specifically, attempts comprising solution based methods,<sup>[13,16–18]</sup> thermal evaporation of PbI<sub>2</sub> in what was called a two-step deposition method,<sup>[19]</sup> and more recently, dipping vapor deposition have all led to significant  $V_{oc}$  losses.<sup>[20]</sup> Subsequent studies by means of a thermal co-evaporation process were made with the aim of improving the continuity of the perovskite film and its impact on the resulting efficiency.<sup>[15]</sup> In this way,  $V_{oc}$  values higher or equal to 1 V with no significant variations were observed using perovskite films as thin as 40 nm with a striking AVT value of 35%, and a *PCE* of 3.39%. Whether with the use of high-temperature-based TiO<sub>2</sub> as ETL,<sup>[12,13]</sup> the use of innovative buffer layers to reduce parasitic absorption in the device stack,<sup>[21]</sup> the use of electrodes or active layers based on highly energy-intensive evaporation techniques,<sup>[12,13,15]</sup> the full potential of perovskite-based semitransparent photovoltaics towards large-scale production is a concept that remains not fully attained.

In the present manuscript we establish two processes for the fabrication of semitransparent devices using AgNWs as electrode material, leading to an efficiency of 7.68% combined with an AVT of 37% for the full device (42% AVT without electrode) for one process, and 3.55% *PCE* combined with a record transparency of 46% AVT (50% AVT, w.o. electrode) for the other process. This result corresponds to an unprecedented combination of optical transparency and maximum power conversion efficiency. Furthermore, by controlling the morphology and thickness of the perovskite layer we are able to tune the short-circuit photocurrent density ( $J_{sc}$ ) from 5.35 (46% AVT) to a value of 19.10 mA cm<sup>-2</sup> (14% AVT), corresponding to a maximum efficiency of 12.95%.

We previously demonstrated the compatibility of AgNW for processing semitransparent perovskite photovoltaics, although these devices still had lower performance and lack in shelf life.<sup>[11,23]</sup> Using the scalable spray coating technique we created an ohmic contact between ZnO nanoparticles and the AgNW electrode. However, the use of water as main solvent for the AgNW seriously limited the shelf life time of the resulting solar cells, hindering further optimization of this device architecture. Yet, this work paved the way for further investigation. In this work, by replacing water in the AgNW colloidal solution with isopropyl alcohol we demonstrate AgNW top electrodes that no longer compromised the integrity of the resulting device. We show that the resulting devices feature a shelf life comparable to their counterpart with an evaporated silver electrode. The selection of AgNWs as an alternative to sputtered or thermally evaporated metal electrodes offers the possibility of using solution-processed, highthroughput coating methods which are highly beneficial for the bill of materials (BOM) and the energy pay back time (EPBT).<sup>[24]</sup>

### 2. RESULTS AND DISCUSSION

We selected the structure ITO/PEDOT:PSS/MHP/PC<sub>60</sub>BM/ZnO/Electrode (where MHP stands for mix halide perovskite, see Supporting Information for details) due to the potential use of thin ETL and HTL layers, low-temperature processing and hysteresis-free<sup>[16,25]</sup> characteristics (the schematic structure of the device configuration and energy diagram can be found in Figure S1). With this approach we avoid the widely used and costly spiro-OMeTAD, which typically involves a ~300 nm thick layers, and whose functionality relies upon extra doping steps. In addition, the use of this thick, partially oxidized spiro-OMeTAD layer results in parasitic

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absorption leading to a reduction of the AVT<sup>[15]</sup>. Albeit we recently demonstrated the use of water free PEDOT:PSS as a HTL for environmentally-stable inverted perovskite solar cells, again, a very thick layer (~300 nm) is needed.<sup>[26]</sup> Similarly to spiro-OMeTAD, the latter also contributes to parasitic absorption, limiting the device in terms of transparency.

# 2.1. Solvent induced fast crystallization method for opaque devices.

With the aim of producing a compact perovskite layer we applied solvent induced fast crystallization deposition (FCD)<sup>[17,27]</sup> combined with nitrogen flow gas-quenching (GQ)<sup>[28,29]</sup> during the ordinary precursor based method and a step-like annealing profile (see Figure S2 and Supporting Information for details). Using this new approach, whose novelty is based on the correct combination of these three different process conditions, we fabricated opaque devices varying the spin coating speed and the concentration of the precursor solution in order to find an optimum trade-off between photovoltaic parameters and thickness of the active layer (AL) (Table 1). We found PCEs ranging from 10.12% to 15.99% corresponding to AL of 70 nm and 340 nm, respectively. Typical J-V curves from best performing devices are depicted in (Figure 1a and b). We observed no significant impact of the film thickness, neither on the FF nor on  $V_{oc}$ . The FF values ranged from 78.62% to 71.70% and  $V_{oc}$  remains constant among all thicknesses, suggesting that a continuous and robust active layer film could be achieved via FCD-GQ at relatively low annealing temperatures (under 140 °C). To further investigate the accuracy of the  $J_{sc}$  obtained from the solar simulator, we recorded the external quantum efficiency (EQE) of the opaque devices (Figure 1-a). We found an agreement between the  $J_{sc}$  calculated from the EQE and that obtained from the *J-V* characterization within 6% of discrepancy. A key collection of

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photovoltaic metrics, deduced from Figure 1, is depicted in Table 1. Additionally, complementary information including statistical relevant parameters can be found in Table S1 and Table S2.

The optical density (OD) spectra of bare AL films show an increase in the absorbance as the film thickens, which is in agreement with the integrated  $J_{sc}$  obtained by the EQE measurements, their corresponding *J-V* curves (Figure 1-c and d) and previously reported trends.<sup>[19,20]</sup> We note that we observed a thickness limit with our method. For bare AL films deposited at speeds lower than 700 rpm, corresponding to thicknesses higher than 340 nm, we observed a downtrend in the OD in the wavelength regime lower than 500 nm (Figure S3). A change in the absorption spectrum suggests a difference in conformation of the resulting perovskite film, most likely due to incomplete crystallization. In light of these findings, we determined that the application of FCD-GQ is revelry limited for devices with perovskite layers exceeding 350 nm, producing low quality, visibly opaque films, suggesting a change in the film roughness (cf. AFM micrographs below). Moreover, the resulting devices denote a significant drop in performance; leading to poor reproducibility, decrease in the shunt resistance and  $V_{oc}$ , ranging from 0.5 to 0.7 V at best (due to lack of statistic consistency on these devices, *J-V* characterization is not shown).

The *EQE* spectra of corresponding devices showed a well-defined signature structure with 4 distinct features shifting to higher wavelengths as the thickness of the film is increased, most likely attributed to optical interference (Figure 1-d and e). The characteristic optical behavior is in agreement with previously reported findings<sup>[30]</sup> and its attributed to optical interference effects. Moreover, the strong dependence of the *EQE* spectral shape on the active

layer thickness suggests optically clean interfaces, which is a desirable attribute for a planar PV architecture.

The perovskite films were further analyzed by means of grazing incidence X-ray diffraction (GIXRD) (Figure 1-d). The GIXRD patterns show sharp and strong peaks at 14.18° and 28.46°, with variations on the full width half maximum (FWHM) below 2%. These peaks are associated with the Miller indices (110) and (220) of the tetragonal phases of perovskite.<sup>[31–33]</sup> The GIXRD peak ratio between (110) and (220) was found to be 12.5, 13.9, 12.3 and 11.8 for the films of 339, 139, ~100 and 70 nm thick perovskite, respectively. These ratios are in the same range for all the thicknesses, suggesting that no significant compositional or overall crystal orientation change was induced by changing the coating speed or the precursor concentration. Furthermore, the (110):(220) peak ratio observed in films without the implementation of FCD and GQ was considerably decreased to a value of 4 (Figure S4). As evidenced by the GIXRD study, two main differences can be elucidated compared to the standard method (without FCD -GQ). The first is a strong increase in the crystallinity as evidenced by the higher overall peak intensity for films with the same thickness. The second is a strong crystallographic phase orientation, as depicted by the (110):(220) intensity ratios. These two characteristics redound to better performance and the possibility of tuning the resulting  $J_{sc}$  by changing the thickness of the AL without jeopardizing  $V_{oc}$  or FF. The peaks at 35° and 51° are characteristic of the underlying ITO layer, also explaining their intensity gain as the film becomes thinner (Figure S4). The pattern associated with the presence of PEDOT:PSS is screened in the case of the thicker layer, being observable at 30° only in the films with 139, 100 and 70 nm thick perovskite (Figure S4).

In order to study differences in morphology we performed atomic force microscopy (AFM) on films with increasing thickness. As is apparent from the micrographs in Figure 2, the welldefined micro-structured domains increase markedly in size with increasing film thickness. Our method leads to grain sizes as large as 6.5 microns for the thicker films and as small as 0.86 microns for the thinner films. Consequently, the roughness (rms) of the resulting films increased from 14.0 nm to 48.3 nm for the 70 and 339 nm films, respectively. However, this increase in roughness did not have an impact on device performance, showing a maximum FF of 76.06% for devices fabricated with 339 nm thick-48.3 rms films. We further evaluated the morphology of the large- and small- perovskite domains in full devices through cross sectional imaging by means of high resolution scanning electron microscopy (SEM). A strong contrast between the different layers and the well-defined edges indicates no obvious interlayer diffusion. In the case of thinner films, several cavities throughout the AL layer that appear to be hollow were observed (Figure 3, label no. 1). We therefore propose that in the case of ultra-thin films, these hollow spaces are generated as a result of the fast acceleration speed in the early stages of the deposition. Owing to this rapid acceleration, the contact time of the exhaust volume with the underlying PEDOT: PSS layer is not sufficient to spread evenly, hence leaving uncovered areas that will later turn into caves. Different features on the cross sectional micrographs of thicker films (238 nm and 339 nm) can be recognized. The surface topography of the perovskite layers shows a step-like sharp profile. This step-like topography can be associated with the domain edges shown by the AFM micrographs, being comparable in size and shape (Figure 3, solid red line). Given the fact that the contrast in electron microscopy correlates with the electron density, it can be depicted by the label number 2 in Figure 3 (bright contrast) what appears to be the formation of small domains with higher electron density. These small features at the interface suggest a change in the compositional atomic mass, surface topography and potentially crystal orientation, owing to the implementation of FCD and GQ. During the FCD, with the addition of a copious

amount of Chlorobenzene in the final stages of the deposition, the solubility of the precursor at the surface is reduced significantly, thereby, promoting fast nucleation and growth of more oriented crystals. Subsequently, the function of the nitrogen GQ is to further stimulate nucleation along with rapid crystal growth during a drying/supersaturation stage. The latter facilitates the formation of the observed large domains. In this way, we imagine the growth of crystalline domains is only limited by the volume of precursor available and its concentration, hence determined by the speed of the deposition, which also defines the final thickness of the film. This explains why the domain size observed in the AFM micrographs becomes larger as the speed of the deposition is decreased. A third feature in the form of round "bubble-like" spots can be distinguished in the SEM cross sections. We attribute the presence of these spots to a measurement artifact, since we observed them appear and disappear during the measurement. It is important to emphasize that the features depicted by label 2 in the top interface of the perovskite layers did not change/emerge during the measurement.

# 2.2. Solvent induced fast crystallization method for semitransparent devices.

After demonstrating a new and simple protocol for the deposition of ultra-thin perovskite films without hampering the resulting performance, our further interest was to elaborate semitransparent devices by employing AgNW electrodes instead of evaporated silver. By using the spray coating technique in air, we deposited a thin layer of AgNW on top of the ZnO buffer layer (Figure S1). The utilization of a mask allowed defining the active area. The final deposited AgNW film had a total transmittance of ~85% at 550 nm. In order to control the sheet resistance of the coated AgNW electrode, we coated glass substrates along with the solar cells and measured the sheet resistance using the four-point probe technique. The measured sheet resistance of the reference AgNW-coated glass ranged between 10 ohms sq<sup>-1</sup> and 20 ohms sq<sup>-1</sup>.

We found that these variations in sheet resistance have a negligible impact on the device performance. We further observed, through control experiments, that the short exposure times of the half-cell (solar cell stack without the electrode) to the environment t (20-30 minutes, 40% RH at room temperature) did not have a negative impact on the device. The ZnO buffer layer was activated with a short exposure (10 s) to UV radiation.<sup>[34]</sup>

Current-voltage curves of best performing semitransparent devices can be seen in Figure 4-a-b. A summary of key parameters is presented in Table 2. In addition, a complete collection of transparency parameters along with complementary statistics for device evaluation is shown in Table S3 and Table S4. Similar to its opaque counterparts, the  $J_{sc}$  drawn from the electrical characterizations is consistent with the optical properties of the AL and with the EQE measurements (Figure 4-a and Figure 1-e). As can be seen from the EQE spectral shape (Figure 4-a and c), the absence of the back electrode is evident for most of the cases and results in a lower J<sub>sc</sub>, showing the characteristic non-reflective nature of the AgNW electrode. As expected, this effect is more significant for the thinner (70 nm) perovskite films, where a larger fraction of photons impinging on the AL remain unabsorbed, leading to a more pronounced drop in  $J_{sc}$ . The resulting efficiencies ranged from 7.81% - ~37% AVT to 12.78% - ~18% AVT. The total transmittance profile for all devices with and without electrode is shown in Figure4-c. The AVT without the electrode reached 42% for the solar cells with thinner (70 nm) AL film (27% of transmittance at 550 nm). The  $J_{sc}$  losses as compared with the same device geometry using evaporated silver were 27.54%, 9.93%, 2.57% and 14.67% for the films of 70 nm, 100 nm, 129 nm and 340 nm, respectively, i.e., we observe an optimum AL thickness of 129 nm for optimum current generation / extraction in combination with a AgNW electrode. Moreover, the observed FF was overall constant within the statistical error (Table S4). We obtained a general drop in FF

of 6% when employing AgNW as compared with evaporated silver. The small impact on the FF can be attributed to the utilization of ultra-thin ETL, HTL and buffer layers, allowing efficient charge extraction and transfer at low optical losses. Moreover, we infer that the highly oriented perovskite crystals allow optimum charge extraction in at the AL/ETL interface. In order to analyze any transient photovoltaic effect in the semitransparent devices we measured the power conversion efficiency (*PCE*) over time. In Figure 4-f we show a representative *PCE* trace vs. time during cyclic illumination. The voltage at maximum power point  $(V_{max})$  and the measured photocurrent density at maximum power point  $(J_{max})$  defines the PCE over time. The  $V_{max}$ interpolation is done on J-V curves performed every second through a  $V_{max}$  tracking algorithm. The quick transient photocurrent response further suggests no hysteretic effect in our semitransparent devices. In addition, we did not observe any decay in the steady-state response of the devices, suggesting a robust charge extraction mechanism (Figure S5). These results inform that water free AgNW electrodes feature suitable optical and electrical characteristics as well as high chemical compatibility with the perovskite layer to form efficient and robust semitransparent photovoltaics.

In addition, in Figure 1-e and Figure 4-e we present the internal quantum efficiency (IQE) evaluation of the best performing opaque and semitransparent devices, respectively. The IQE was derived using a systematic approach reported elsewhere<sup>[35,36]</sup>. In order to consider the electro-optical cavity effects into the IQE calculation we performed accurate total reflectance and transmittance measurements along with a transfer-matrix assessment of all non-active parasitic absorbances including the AgNW electrode for the semitransparent devices (schematic workflow depicted in Figure S7). The resulting spectral shape of the IQE for the opaque device is in agreement with previously reported results within the limitations of the experimental error<sup>[30,37]</sup>.

The *IQE* spectral shape shows an overall semi-flat behavior and in the vicinity of 100% for both architectures showing no significant influence of hot exciton or charge carriers effects as well as no energy dependent charge generation. Likewise, this analysis further confirms the almost perfect charge generation and subsequent collection of our perovskite devices. Additionally, for the case of the semitransparent devices it also confirms the efficiency and robustness of the AgNW as an electrode alternative.

#### 2.3. Solvent-solvent extraction method for semitransparent devices.

To overcome the transparency limitations given by the utilization of the FCD-GQ method, we developed a new protocol based on the solvent-solvent extraction method (SSE). During the SSE method, the partially dry perovskite film is rapidly submerged into an extraction solvent. The high miscibility between the precursor-solvent and the extraction-solvent allows diffusion of the solvent contained in the film, thus inducing crystallization. During crystallization, the definition of the chemical environment with the correct selection of solvents is crucially important for crystal growth <sup>[38]</sup>. Commonly used precursor solvents for the solution process preparation of perovskite-based solar cells are  $\gamma$ -butylrolactone (GBL, dielectric constant,  $\varepsilon = 39.1$ ), *N*,*N*-dimethylformamide (DMF) ( $\varepsilon = 38.3$ ) and dimethylsulfoxide (DMSO) ( $\varepsilon = 47.2$ ), due to their high solubility and moderate coordination properties. Crystallization of CH<sub>3</sub>NH<sub>3</sub>PbI<sub>3</sub> with the use of  $\gamma$ -butylrolactone as precursor solvent has successfully lead to high quality single crystal growth by means of the vapor-assisted crystallization method<sup>[39]</sup>. Furthermore GBL does not induce adduct formation with PbI<sub>2</sub> like in the case of DMSO (PbI(DMSO)<sub>2</sub>), which will retard

the crystallization when performed at room temperature, potentially leading to poor film quality<sup>[40,41]</sup>.

In the present case, we explored  $\gamma$ -butyrolactone ( $\epsilon_{GBL} = 39.1$ ,  $bp_{GBL} = 204$  °C) as precursor solvent due to its high boiling point and dielectric constant (see experimental section for further details). During this process, the perovskite film is rapidly submerged either in toluene, TE ( $\epsilon_{TE} = 2.38$ ,  $\mu_{TE} = 0.36$  D) or in diethyl ether, DEE ( $\epsilon_{DEE} = 4.20$ ,  $\mu_{DEE} = 1.15$  D) as the extraction solvent to induce fast crystallization. Both toluene and diethyl-ether have been previously reported mainly for controlled precipitation of CH<sub>3</sub>NH<sub>3</sub>PbI<sub>3</sub> perovskite micro- and nanoparticles extracted from GBL precursor solution<sup>[42]</sup>.

As apparent from Figure 5-a, Figure S8 and supplemental video, the deposited precursor changes color almost instantly when in contact with the extraction solvent. The precursor film darkens within the first 5 seconds. Notably, the use of toluene induces faster change in color compared to diethyl ether, potentially due to incomplete crystallization in the case of diethyl ether.

The rapid nature of the crystallization process (supersaturation, nucleation and crystal growth under 5 seconds) facilitates full deposition of all layers under ambient conditions in the presence of a relatively high humidity (45%RH) and with good reproducibility (Table S5 and Figure S6). Zhou *et al.*<sup>[43]</sup> reported a similar approach with the utilization of *N*-methyl-2-pyrrolidone (NMP,  $\varepsilon_{NMP} = 39.1$ ,  $bp_{NMP} = 202$  °C) as precursor solvent and DEE as extraction solvent. However, in that case the crystallization of CH<sub>3</sub>NH<sub>3</sub>PbI<sub>3</sub> took about 2 min. In our case, we observed a much shorter crystallization time (under 5 seconds) while still producing high quality and homogeneous thin perovskite films.

Using toluene and DEE as extraction solvents in the solvent-solvent extraction method, we were able to fabricate devices with comparable performance than with fast crystallization deposition (Figure 6). However, using the solvent-solvent extraction method, particularly in the presence of toluene (SSE-TE), we observed significantly better photovoltaic performances when fabricating ultrathin perovskite films (40 nm) as compared to fast crystallization deposition (Figure S9). By applying SSE-TE we were able to fabricate devices with an unprecedented 46% AVT for a full device stack, corresponding to 45% total transmittance at 550 nm, while yielding a *PCE* of 3.6% based on a *FF* of 65.6%, and a  $V_{oc}$  of 1.03 V. Current-voltage curves of best performing semitransparent devices along with their *EQE* profiles and total transmittance spectra are depicted in Figure 5. A summary of the key parameters is presented in Table 1. In addition, a complete collection of transparency values along with complementary statistics for device evaluation is shown in Table S5 and Table S6.

Finally, in order to correlate transparency and color perception as well as provide a global perspective of our results, we simulated trends for the short-circuit photocurrent as a function of total transmittance at 550 nm (Figure 6-a) and as a function of active layer thickness (Figure 6-b). Additionally, we calculated and plotted the color coordinates of empirical and simulated semitransparent perovskite solar cells in a CIE xy 1931 chromatic diagram (Figure 6-c). The simulated and experimental short-circuit current data agree closely, confirming the validity of the simple layers optical constants (Figure S10). With the combination of the presented experimental methods and optical simulations we are able to cover a wide range of thicknesses and transparencies for perovskite devices, therefore, opening a plurality of potential applications. Since, in addition to modular transparency, aesthetic or complete neutral-color appearance is a desired property for building integration applications we simulated the color coordinates for a

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broad range of devices with the active layer thickness extending from 0 nm to 500 nm (Figure 6c). Most importantly and as desired for building integrated photovoltaics (BIPV), the chromaticity coordinates corresponding to the sample SSS-TE2 are located in the vicinity of the neutral zone of the CIE diagram, which positions perovskites as a very competitive technology for the BIPV market.

# 3. CONCLUSIONS

In conclusion, we developed a systematic approach for the preparation of highly transparent and highly efficient solar cells using water free AgNW electrodes. We fabricated semitransparent perovskite solar cells at relatively low temperatures utilizing a process that is fully solution based and without being afflicted by hysteresis. We introduced a methodology based on a combination of solvent induced fast crystallization and gas quenching in order to assist the perovskite crystallization process during the late stages of deposition. We infer that this methodology leads to highly oriented crystals, presumably extending to the interface, where efficient charge extraction can occur. Furthermore, we introduce a solvent-solvent extraction protocol to increase the dynamic transparency range of the studied architecture. This protocol allows complete device fabrication in ambient conditions even at relatively high humidity conditions including complete crystallization of the perovskite precursor deposited layer within a 5 seconds period of time and it does not require any type of annealing. Moreover, by associating photovoltaic parameters, such as open circuit voltage and fill factor, with the quality of the perovskite layer, we demonstrated the elaboration of a highly compact, pinhole-free and ultra-thin active layer, allowing us to fabricate semitransparent solar cells with an unprecedented average visible transparency of 46%

combined with an efficiency of 3.55%, based on a high fill factor of 65.55% and open circuit voltage of 1.03 (see Figure S11). We demonstrated technical relevance our method using a robust statistical analysis, showing excellent reproducibility. Hence, this study successfully realizes a robust perovskite-based absorber with elevated extinction coefficient in an ultra-thin configuration without jeopardizing photovoltaic performance and, therefore, leads the way for a successful implementation in high throughput printing technologies.

# MATERIALS AND METHODS

*Materials and preparation:* Unless stated otherwise, all materials were used as received and were purchased by Merck or Aldrich. Lead (III) Chloride ultra dried 99.99% ampouled under Argon was purchased from Alfa Aesar and CH<sub>3</sub>NH<sub>3</sub>I was provided by Dyenamo. Neutral-PEDOT:PSS (Clevios SCA 228) was provided by Heraeus. Nanograde provided ZnO nanoparticle ink; anhydrous solvents and short exposures to air were used during its preparation upon request. **The DMF-perovskite precursor** solution was made by adding PbCl<sub>2</sub> and CH<sub>3</sub>NH<sub>3</sub>I powders with a molar ratio of 1:3 and a concentration of 40 wt% and 30 wt% to a vial and mixed with anhydrous Dimethylformamide (DMF). The solution was then stirred for 30 minutes at 60 °C and filtered prior to deposition. The **GBL-perovskite precursor** was made by adding PbI<sub>2</sub> and CH<sub>3</sub>NH<sub>3</sub>I powders to a vial and mixed with anhydrous gamma-Butyrolactone (GBL). The solution was then stirred for 30 minutes at 60 °C and filtered prior to deposition. Isopropanol based AgNW ink with a 1 wt% load was provided by Rent A Scientist (RAS). Individual solvents comprising the ink were tested to evaluate whether the perovskite film can withstand its exposure, this would be evident by a

change in color from dark brown to light yellow. Acetone, ethylene glycol, isopropanol and ethyl acetate were tested from which only ethylene glycol proved to be detrimental to the film by this particular test. This solvent was removed from the ink upon request. The AgNW ink was used as received.

*Device fabrication:* Laser patterned ITO (with a roughness of 5-7 RMS) substrates were ultra sonic cleaned using toluene, acetone and isopropanol for 10 minutes each followed by an oxygen plasma cleaning process. The cleaned substrate was then coated with a PEDOT:PSS layer by means of spin coating at a speed of 2000 rpm and annealed at 140 °C for 15 minutes.

After perovskite deposition, a compact ~60 nm thick layer of  $PC_{60}BM$  is spin coated. A 2 wt% solution of  $PC_{60}BM$  in CB is then deposited using a three step speed profile with no subsequent annealing. The ZnO film was spin coated at 2000 rpm and annealed during 5 minutes at 80 °C. For the opaque devices, the counter electrode was deposited through a shadow mask by thermal evaporation under a vacuum of  $10^{-6}$  torr. For the semitransparent devices the AgNW counter electrode was deposited using an automated spray coating system. The obtained thick AgNW film had a sheet resistance of around 10 - 20 ohm sq.<sup>-1</sup> and a transmittance of ~85% at 550 nm.

**FCD-GQ method**: Once at room temperature, the substrates were coated with the DMFperovskite precursor solution with different speeds in order to control the thickness. Two to five seconds before the end of the deposition the samples were drop-casted with 300  $\mu$ L of Chlorobenzene and right after the washing step the sample is readily dried with a nitrogen flow during 10 seconds. Subsequently, the samples were kept on a hot plate at a temperature of 50 °C during a period of approximately 20 minutes followed by a profiled temperature-annealing step (Figure S2), all depositions were performed under inert nitrogen atmosphere.

**Solvent-solvent extraction method**: After PEDOT:PSS deposition, the samples were deposited with the GBL-perovskite precursor *via* spin coating. The concentrations were 40 wt% and 80 wt% for SSE-TE1 and SSE-TE2, respectively. Similarly, the spin coating times and final speeds were, 10 seconds – 4000 rpm and 5 seconds – 6000 rpm for SSE-TE1 and SSE-TE2, respectively. Right after deposition, the samples were submerged into 40 mL of anhydrous Toluene for an average time of 5 seconds; all depositions were performed in ambient conditions (25°C and 45%RH).

Device Characterization: Current density-voltage (J-V) characterization under light was carried out by means of a measurement unit from BoTest using a Newport Sol1A solar simulator with an AM1.5 G spectrum at 0.1 W/cm<sup>2</sup>, which was determined by a calibrated single-crystal standard Si-cell. To avoid current contribution from adjacent pixels during the measurement we utilized a shadowing mask for all J-V characterizations. External quantum efficiency (EQE) spectra were recorded with an Enli Technology QE-R measurement system, also calibrated with a Si PV cell. Cross sections of the samples were obtained with a FEI Helios NanoLab 660 DualBeam FIB system. In order to prepare the samples, a Carbon Gas Injection System (GIS) was used to deposit, in two steps, a thick layer of amorphous carbon over the area of interest. After the protective deposition, the samples were drilled and polished with a beam consisting of Ga+ ions operating at an acceleration voltage of 30 kV with subsequent current polishing steps of 2.5 nA and 80 pA, respectively. Topography images were taken with an atomic force microscope NT-MDT Solver Nano in intermittent contact mode. Optical absorption measurements were performed with a UV-Vis spectrometer Lambda 950 from Perkin equipped with an integrating sphere. Unless stated otherwise all average total transmittance (AVT) values are calculated by

averaging the total transmittance recorded between 400 nm and 800 nm. Thickness of the active layer was determined though measurements on cross section micrographs and/or a profilometer, each value is then obtained as a result of averaging 10 measurements along the film. Grain size was measured with the software for interface design and characterization Magnification, the average values for grain size was then calculated by averaging 100 measurements along an area of  $20 \ \mu m^2$ . <sup>[23,26]</sup>

ID	Thickness (nm)	$EQE J_{sc} (mA \ cm^{-2})$	$J_{sc}$ (mA cm <sup>-2</sup> )	$V_{oc}\left(\mathbf{V}\right)$	FF (%)	$PCE^{l}$
FCD-OP 1	70±14	14.59	15.91	0.96	75.81	10.12
FCD-OP 2	100±17	15.38	16.27	0.96	73.63	10.71
FCD-OP 3	129±18	17.54	18.79	0.94	74.55	12.20
÷	:	÷	÷	÷	÷	÷
FCD-OP 7	339±16	21.93	22.05	0.99	76.06	15.99

Table 1. Key metrics for best performing opaque (OP) devices using the FCD-GQ method.

<sup>1</sup> *PCE* values are calculated using  $J_{sc}$  extracted from EQE measurements.

\* Complete collection of the metrics along with complementary information including statistical relevant parameters can be found in Table S1 and Table S2.

Table 2. Ke	y metrics for	best performin	g semitranspare	ent devices using	the FCD-GQ	method.
	2					

ID	Thickness (nm)	$EQE J_{sc} (mA \ cm^{-2})$	$V_{oc}\left(\mathbf{V}\right)$	FF (%)	$PCE^{l}$	AVT <sup>a</sup> (%)	$AVT^{b}$ (%)
FCD-ST 1	70±14	11.55	0.97	72.23	7.81	42	37
FCD-ST 2	100±17	14.23	0.98	72.07	9.55	33	29
FCD-ST 3	129±18	17.32	0.97	69.38	10.81	28	23
FCD-ST 4	339±16	19.10	0.97	70.85	12.95	18	14

<sup>1</sup> *PCE* values are calculated using  $J_{sc}$  extracted from EQE measurements.

<sup>a</sup> Average visible transmittance for devices without top electrode.

<sup>b</sup> Average visible transmittance for devices with top electrode.

\* Complete collection of metrics along with complementary information including statistical relevant parameters can be found in Table S3 and Table S4.

ID	Thickness (nm)	EQE, Sol. Sim. <sup>1</sup>	$V_{oc}\left(\mathbf{V}\right)$	FF (%)	$PCE^1$	AVT <sup>a</sup> (%)	$AVT^{b}$ (%)
		$J_{sc}$ (mA cm <sup>-2</sup> )					
SSE-TE 1	100±14	9.55, 11.22	1.03	71.77	8.12	33	28
SSE-TE 2	50±17	4.37, 5.35	1.03	65.55	3.55	50	46

Table 3. Key metrics for best performing semitransparent devices using the SSE method using toluene as extraction solvent.

<sup>1</sup>  $\overline{PCE}$  values are calculated using short circuit photocurrent extracted from *J-V* characterization AM 1.5 irradiation at 0.1 W/cm<sup>2</sup> illumination.

<sup>a</sup> Average visible transmittance for devices without top electrode.

<sup>b</sup> Average visible transmittance for devices with top electrode.

\* Complete collection of metrics along with complementary information including statistical relevant parameters can be found in Table S5.



Figure 1. a) J-V characteristics under AM 1.5 irradiation at 0.1 W/cm<sup>2</sup> illumination for devices with average FF as a function of active layer thickness; b) Corresponding dark current; c) absorption spectra for bare active layer films produced with the FCD-GQ method; d) *EQE* spectra for opaque devices with increasing active layer thickness; e) *IQE* evaluation of best performing perovskite opaque device with the FCD-GQ method. f) GIXRD spectra of bare films produced with the FCD-GQ method.



Figure 2. Topography of MAPbI<sub>3-x</sub>Cl<sub>x</sub> films with different active layer thicknesses as measured by intermittent contact atomic force microscopy (AFM). The column on the left shows 20  $\mu$ m x 20  $\mu$ m areas. The column on the right shows 5  $\mu$ m x 5  $\mu$ m area.



Figure 3. Cross-section scanning electron microscopy (SEM) micrographs of full opaque devices. Labels 1, 2 and 3 point out different features or artifacts in the film (see text for details). The specifications of the microscope for all SEM image acquisitions were: Thermoluminescent dosimeter (TLD) detector with a magnification of 65000 x, a current of 0.10 nA, dwell of 500 ns, HFV 3.9  $\mu$ m and a HW of 3.7 mm.



Figure 4. a) J-V characteristics under AM 1.5 spectrum at 0.1 W/cm<sup>2</sup> illumination for devices with optimum FF as a function of active layer thickness; b) Corresponding dark current; c) Total transmittance spectra of full devices with top AgNW electrode and without top AgNW electrode; d) EQE spectra for semitransparent devices with increasing thickness; e) IQE evaluation of best performing perovskite opaque device with the FCD-GQ method; f) Photocurrent response of semi-transparent device FCD-ST 4 for three light on – off switching cycles.



Figure 5. a) Schematic representation of the SEE method showing 5 seconds crystallization and final appearance of a full semitransparent cell, no extra annealing for the perovskite film is needed; b) Total transmittance spectra of full devices with top AgNW electrode and without top AgNW electrode; c) J-V characteristics under AM 1.5 spectrum at 0.1 W/cm<sup>2</sup> illumination for devices with optimum FF; e) *EQE* spectra for semitransparent devices using the SEE-TE method.



Figure 6. a) Simulated behavior of the short circuit photocurrent ( $J_{sc}$ ) as a function of active layer thickness; b) Simulated Transmittance at 550 nm as a function of  $J_{sc}$ . The  $J_{sc}$  utilized for this plots was extracted from *J-V* characterization AM 1.5 irradiation at 0.1 W/cm<sup>2</sup> illumination. c) Color coordinates of the full semitransparent perovskite solar cell plotted on the CIE xy 1931 chromatic diagram showing: devices fabricated with the FCD-GQ method under inert atmosphere (blue circle), devices fabricated with the SSE-TE method in ambient conditions (25°C, 45 %RH) (green square), and simulated values with thicknesses ranging from 0 nm to 500 nm in intervals of 100 nm, solid black line and black triangle, respectively.

# AUTHOR INFORMATION

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